

XI'AN IR-PERI



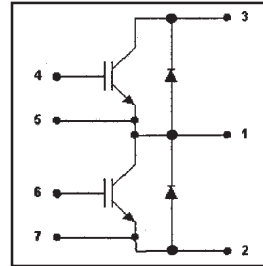
PRELIMINARY

GA100TS60K

"HALF-BRIDGE" IGBT INT-A-PAK

Features

- GEN5 NPT Technology
- Low $V_{ce(on)}$
- 10us Short Circuit Capability
- Square RBSOA
- Positive $V_{ce(on)}$ Temperature Coefficient
- HEXFRED™ antiparallel diodes with ultra- soft recovery
- Industry standard package



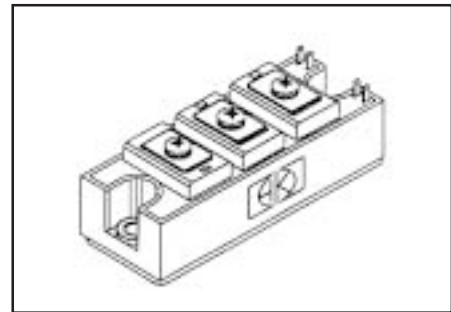
$V_{CES} = 600V$

$V_{CE(on) typ.} = 1.9V$

@ $V_{GE} = 15V, I_C = 100A$

Benefits

- Increased operating efficiency
- Rugged Transient Performance
- Performance optimized for power conversion: UPS, SMPS, Welding; Benchmark Efficiency for Motor Control Applications
- Excellent Current Sharing in Parallel Operation
- Lower EMI, requires less snubbing



Absolute Maximum Ratings

	Parameter	Max.	Units
V_{CES}	Collector-to-Emitter Voltage	600	V
$I_C @ T_C = 70^\circ C$	Continuous Collector Current	100	A
I_{CM}	Pulsed Collector Current*	200	
I_{LM}	Peak Switching Current,	200	
I_{FM}	Peak Diode Forward Current	200	
V_{GE}	Gate-to-Emitter Voltage	± 20	V
V_{ISOL}	RMS Isolation Voltage, Any Terminal To Case, $t = 1 \text{ min}$	2500	
$P_D @ T_C = 25^\circ C$	Maximum Power Dissipation	417	W
$P_D @ T_C = 85^\circ C$	Maximum Power Dissipation	220	
T_J	Operating Junction Temperature Range	-40 to +150	$^\circ C$
T_{STG}	Storage Temperature Range	-40 to +125	

Thermal / Mechanical Characteristics

	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case - IGBT	—	0.30	$^\circ C/W$
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case - Diode	—	0.70	
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink - Module	0.1	—	
	Mounting Torque, Case-to-Heatsink	—	4.0	N·m
	Mounting Torque, Case-to-Terminal 1, 2 & 3③	—	3.0	
	Weight of Module	200	—	g

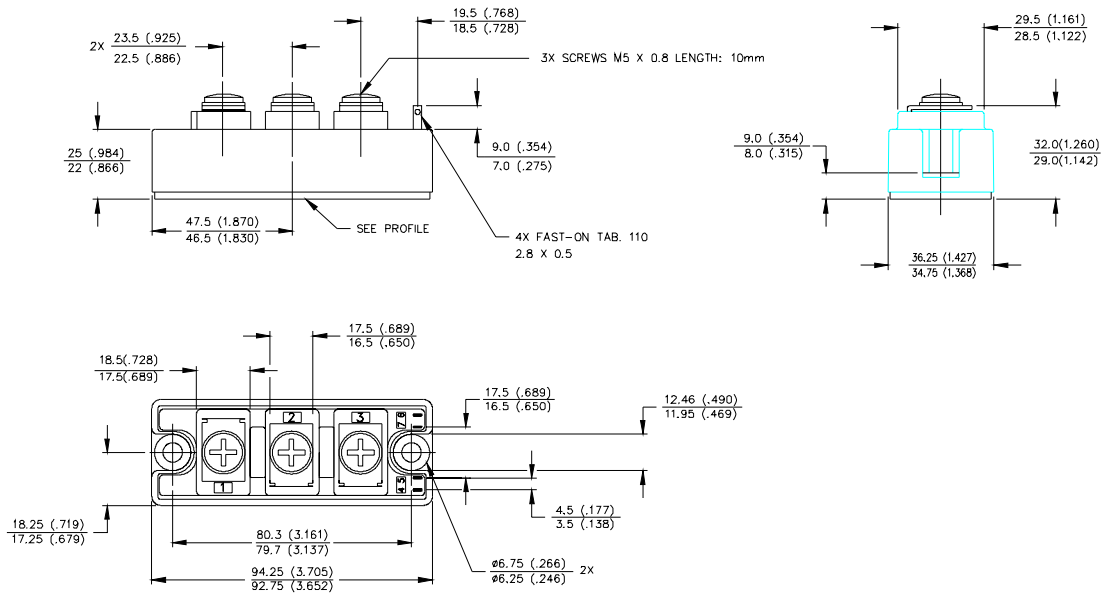
Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)CES}$	Collector-to-Emitter Breakdown Voltage	600	—	—	V	$V_{GE} = 0V, I_C = 1mA$
$V_{CE(on)}$	Collector-to-Emitter Voltage	—	1.9	2.1		$V_{GE} = 15V, I_C = 100A$
		—	2.15	—		$V_{GE} = 15V, I_C = 100A, T_J = 125^\circ\text{C}$
$V_{GE(th)}$	Gate Threshold Voltage	4.5	5.1	5.5		$I_C = 250\mu A$
I_{CES}	Collector-to-Emitter Leaking Current	—	—	100	uA	$V_{GE} = 0V, V_{CE} = 600V$
		—	—	100		$V_{GE} = 0V, V_{CE} = 600V, T_J = 125^\circ\text{C}$
V_{FM}	Diode Forward Voltage - Maximum	—	1.5	—	V	$I_F = 100A, V_{GE} = 0V$
		—	1.4	—		$I_F = 100A, V_{GE} = 0V, T_J = 125^\circ\text{C}$
I_{GES}	Gate-to-Emitter Leakage Current	—	—	1.1	uA	$V_{GE} = \pm 20V$

Dynamic Characteristics - $T_J = 125^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
Q_g	Total Gate Charge (turn-on)	—	443	664	nC	$V_{CC} = 400V$
Q_{ge}	Gate - Emitter Charge (turn-on)	—	86	129		$I_C = 66A$
Q_{gc}	Gate - Collector Charge (turn-on)	—	150	225		$T_J = 25^\circ\text{C}$
$t_{d(on)}$	Turn-On Delay Time	—	35	—	ns	$R_{G1} = 3.3\Omega, R_{G2} = 0\Omega$
t_r	Rise Time	—	12	—		$I_C = 100A$
$t_{d(off)}$	Turn-Off Delay Time	—	135	—		$V_{CC} = 360V$
t_f	Fall Time	—	30	—		$V_{GE} = \pm 15V$
E_{on}	Turn-On Switching Energy	—	1.0	—	mJ	
$E_{off(1)}$	Turn-Off Switching Energy	—	3.3	—		
$E_{ts(1)}$	Total Switching Energy	—	4.3	9		
C_{ies}	Input Capacitance	—	9837	—	pF	$V_{GE} = 0V$
C_{oes}	Output Capacitance	—	615	—		$V_{CC} = 30V$
C_{res}	Reverse Transfer Capacitance	—	128	—		$f = 1\text{ MHz}$
t_{rr}	Diode Reverse Recovery Time	—	143	—	ns	$I_C = 100A$
I_{rr}	Diode Peak Reverse Current	—	95	—		$R_{G1} = 27\Omega$
Q_{rr}	Diode Recovery Charge	—	6813	—	nC	$R_{G2} = 0\Omega$
$di_{(rec)M}/dt$	Diode Peak Rate of Fall of Recovery During t_b	—	1883	—	A/ μs	$V_{CC} = 360V$ $di/dt \gg 1300A/\mu s$

Case Outline — INT-A-PAK



Dimensions are shown in millimeters (inches)